Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/715,447	FUJII ET AL.	
Examiner	Art Unit	
Sanh D. Phu	2618	

	SEARCHED					
Class	Subclass	Date	Examiner			
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	410					
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	6/21/06	Sp		